Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/622,286	BRICKELL, ERNIE F.
Examiner	Art Unit
Baotran N. To	2135

SEARCHED				
Class	Subclass	Date	Examiner	
713	156-158	1/17/2008	ВТ	
713	173, 175	1/17/2008	ВТ	
726	10	1/17/2008	ВТ	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH (USPAT; USPGPUB; EPO; JPO; DERWENT; IBM_TDB)	1/17/2008	ͺΒΤ
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